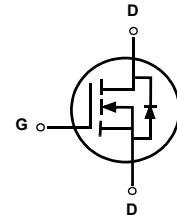


FDP8878**N-Channel Logic Level PowerTrench® MOSFET**
30V, 40A, 15mΩ**General Descriptions**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(ON)}$ and fast switching speed.

**Features**

- $r_{DS(ON)} = 15\text{m}\Omega$, $V_{GS} = 10\text{V}$, $I_D = 40\text{A}$
- $r_{DS(ON)} = 19\text{m}\Omega$, $V_{GS} = 4.5\text{V}$, $I_D = 36\text{A}$
- High performance trench technology for extremely low $r_{DS(ON)}$
- Low gate charge
- High power and current handling capability
- RoHS Compliant

MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|----------------|--|------------|------------------|
| V_{DSS} | Drain to Source Voltage | 30 | V |
| V_{GS} | Gate to Source Voltage | ± 20 | V |
| I_D | Drain Current | | |
| | Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$) | 40 | A |
| | Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 4.5\text{V}$) | 36 | A |
| | Pulsed (Note 4) | 141 | A |
| E_{AS} | Single Pulse Avalanche Energy (Note 1) | 60 | mJ |
| | $L = 1\text{mH}, I_{AS} = 11\text{A}$ | 22 | |
| P_D | Power dissipation | 40.5 | W |
| T_J, T_{STG} | Operating and Storage Temperature | -55 to 175 | $^\circ\text{C}$ |

Thermal Characteristics

| | | | |
|-----------------|--|-----|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case (Note 2) | 3.7 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient at 1000 seconds (Note 3) | 43 | $^\circ\text{C/W}$ |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|---------|---------|-----------|------------|----------|
| FDP8878 | FDP8878 | TO-220 | Tube | n/a | 45 units |

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|-----------------------------------|-------------------------------------|---|-----|-----|-----------|---------------------------|
| Off Characteristics | | | | | | |
| B_{VDSS} | Drain to Source Breakdown Voltage | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ | 30 | - | - | V |
| ΔB_{VDSS} ΔT_J | Breakdown Voltage Temp. Coefficient | $I_D = 250\mu\text{A},$ Referenced to 25°C | | 21 | | mV°C |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24\text{V}$ $V_{GS} = 0\text{V}$ | - | - | 1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20\text{V}$ | - | - | ± 100 | nA |

On Characteristics

| | | | | | | |
|--|---|---|-----|-----|-----|---------------------------|
| $V_{GS(\text{TH})}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ | 1.2 | 1.7 | 2.5 | V |
| $\Delta V_{GS(\text{TH})}$ ΔT_J | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\mu\text{A},$ Referenced to 25°C | | -5 | | mV°C |
| $r_{DS(\text{ON})}$ | Drain to Source On Resistance | $I_D = 40\text{A}, V_{GS} = 10\text{V}$ | - | 12 | 15 | $\text{m}\Omega$ |
| | | $I_D = 36\text{A}, V_{GS} = 4.5\text{V}$ | - | 16 | 19 | |
| | | $I_D = 40, V_{GS} = 10\text{V},$ $T_A = 175^\circ\text{C}$ | - | 20 | 25 | |

Dynamic Characteristics

| | | | | | | |
|---------------------|----------------------------------|---|-----------------------|------|------|----------|
| C_{ISS} | Input Capacitance | $V_{DS} = 15\text{V}, V_{GS} = 0\text{V},$ $f = 1\text{MHz}$ | - | 927 | 1235 | pF |
| C_{OSS} | Output Capacitance | | - | 188 | 250 | pF |
| C_{RSS} | Reverse Transfer Capacitance | | - | 1130 | 175 | pF |
| R_G | Gate Resistance | $f = 1\text{MHz}$ | | 3.0 | | Ω |
| $Q_{g(\text{TOT})}$ | Total Gate Charge at 10V | $V_{GS} = 0\text{V to } 10\text{V}$ | $V_{DD} = 15\text{V}$ | - | 17.1 | nC |
| $Q_{g(5)}$ | Total Gate Charge at 5V | $V_{GS} = 0\text{V to } 5\text{V}$ | $I_D = 40\text{A}$ | - | 9.2 | nC |
| Q_{gs} | Gate to Source Gate Charge | $I_g = 1.0\text{mA}$ | | - | 2.6 | nC |
| Q_{gs2} | Gate Charge Threshold to Plateau | | | - | 1.7 | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | - | 3.7 | nC |

Switching Characteristics ($V_{GS} = 10\text{V}$)

| | | | | | | |
|---------------------|---------------------|---|---|------|-----|----|
| t_{ON} | Turn-On Time | $V_{DD} = 15\text{V}, I_D = 40\text{A}$ $V_{GS} = 10\text{V}, R_{GS} = 16\Omega$ | - | 255 | 383 | ns |
| $t_{d(\text{ON})}$ | Turn-On Delay Time | | - | 11.1 | | ns |
| t_r | Rise Time | | - | 244 | | ns |
| $t_{d(\text{OFF})}$ | Turn-Off Delay Time | | - | 14.8 | | ns |
| t_f | Fall Time | | - | 35.3 | | ns |
| t_{OFF} | Turn-Off Time | | - | 50 | 75 | ns |

Drain-Source Diode Characteristics

| | | | | | | |
|----------|-------------------------------|---|---|------|------|----|
| V_{SD} | Source to Drain Diode Voltage | $I_{SD} = 40\text{A}$ | - | 1.1 | 1.25 | V |
| | | $I_{SD} = 3.2\text{A}$ | - | 0.85 | 1.2 | V |
| t_{rr} | Reverse Recovery Time | $I_{SD} = 40\text{A}, dI_{SD}/dt = 100\text{A}/\mu\text{s}$ | - | 14.4 | 18.8 | ns |
| Q_{RR} | Reverse Recovered Charge | $I_{SD} = 40\text{A}, dI_{SD}/dt = 100\text{A}/\mu\text{s}$ | - | 5.1 | 6.7 | nC |

Notes:

- 1: Starting $T_J = 25^\circ\text{C}, V_{DD} = 30\text{V}, V_{GS} = 10\text{V}$
- 2: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
- 3: $R_{\theta JA}$ is measured with 1.0 in² copper on FR-4 board
- 4: Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

Typical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

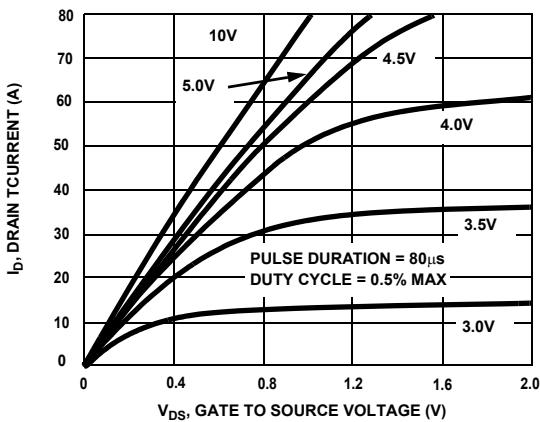


Figure 1. On Region Characteristics

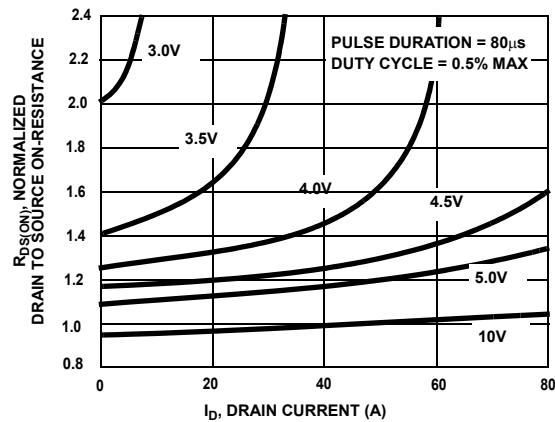


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

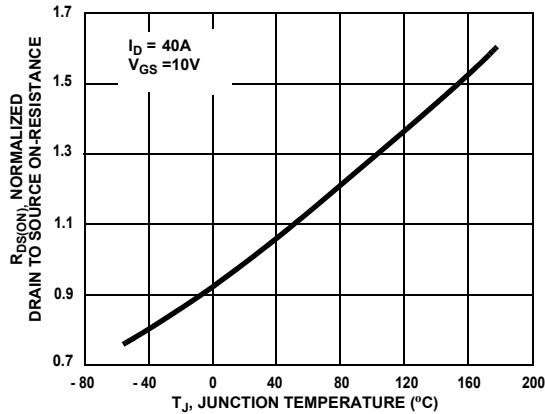


Figure 3. On Resistance Variation with Temperature

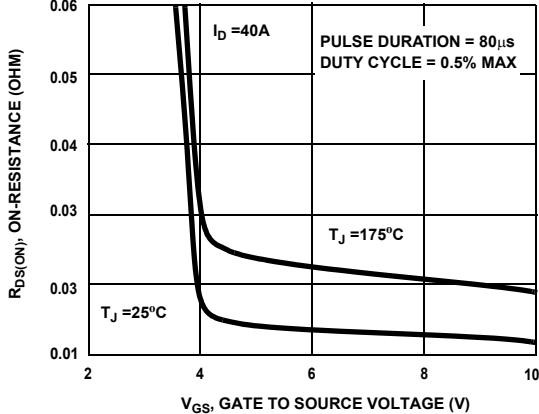


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

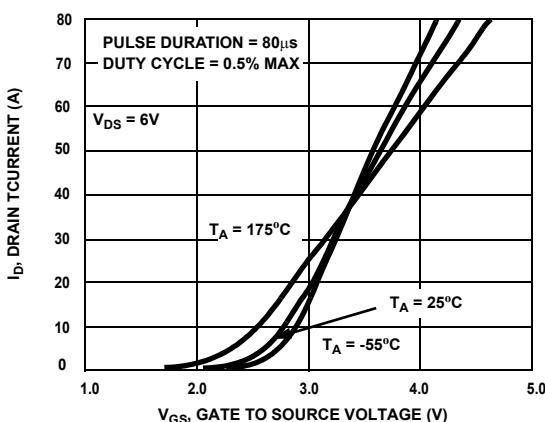


Figure 5. Transfer Characteristics

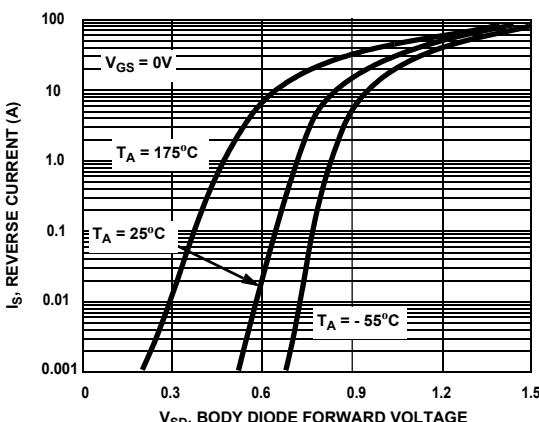


Figure 6. Body Diode Forward Voltage Variation With Source Current and Temperature

Typical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

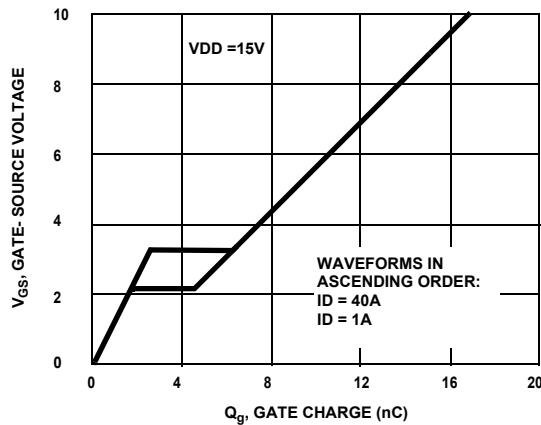


Figure 7. Gate Charge Characteristics

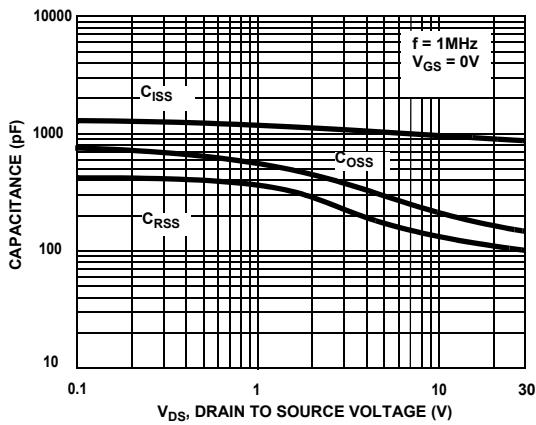


Figure 8. Capacitance Characteristics

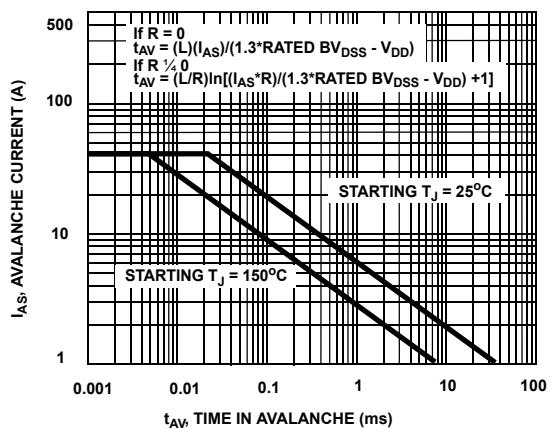


Figure 9. Unclamped Inductive Switching Capability

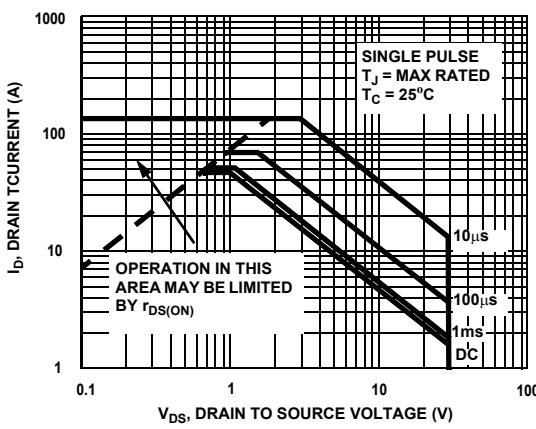


Figure 10. Safe Operating Area

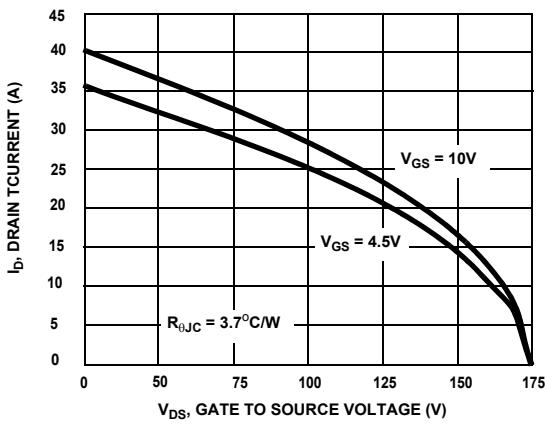


Figure 11. Maximum Continuous Drain Current vs Case Temperature

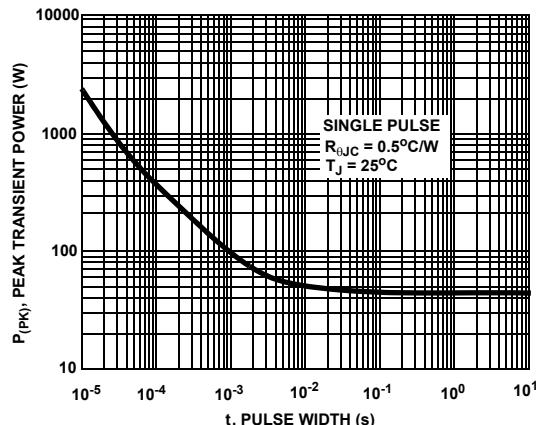


Figure 12. Single Pulse Maximum Power Dissipation

FDP8878 N-Channel PowerTrench® MOSFET

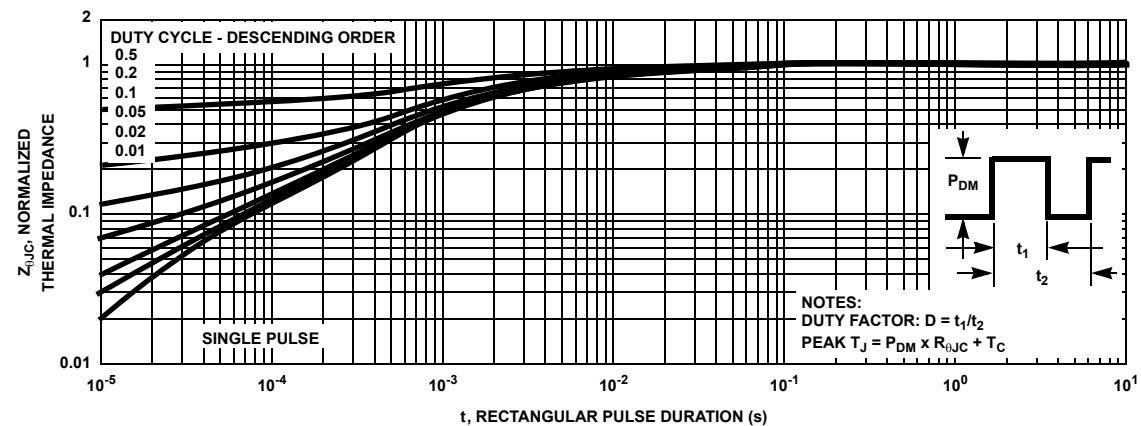


Figure 13. Transient Thermal Response Curve

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

| | | | | |
|--------------------------------------|---------------------|---------------|---------------------|-----------------|
| ACEx™ | FAST® | ISOPLANAR™ | PowerSaver™ | SuperSOT™-6 |
| ActiveArray™ | FASTR™ | LittleFET™ | PowerTrench® | SuperSOT™-8 |
| Bottomless™ | FPSTM | MICROCOUPLER™ | QFET® | SyncFET™ |
| Build it Now™ | FRFETT™ | MicroFET™ | QS™ | TinyLogic® |
| CoolFET™ | GlobalOptoisolator™ | MicroPak™ | QT Optoelectronics™ | TINYOPTO™ |
| CROSSVOLT™ | GTO™ | MICROWIRE™ | Quiet Series™ | TruTranslation™ |
| DOME™ | HiSeC™ | MSX™ | RapidConfigure™ | UHC™ |
| EcoSPARK™ | I²C™ | MSXPro™ | RapidConnect™ | UltraFET® |
| E²CMOST™ | i-Lo™ | OCX™ | μSerDes™ | UniFET™ |
| EnSigna™ | ImpliedDisconnect™ | OCXPro™ | ScalarPump™ | VCX™ |
| FACT™ | IntelliMAX™ | OPTOLOGIC® | SILENT SWITCHER® | Wire™ |
| FACT Quiet Series™ | | OPTOPLANAR™ | SMART START™ | |
| Across the board. Around the world.™ | | PACMAN™ | SPM™ | |
| The Power Franchise® | | POP™ | Stealth™ | |
| Programmable Active Droop™ | | Power247™ | SuperFET™ | |
| | | PowerEdge™ | SuperSOT™-3 | |

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

| Datasheet Identification | Product Status | Definition |
|--------------------------|------------------------|---|
| Advance Information | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary | First Production | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| Obsolete | Not In Production | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only. |

Rev. I17